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Patent
Attorney Docket No. 033808-007

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

Sang-min Yoon et al.

Group Art Unit: 2621

Application No.: 10/699,879

Examiner: Unassigned

Filing Date: November 4, 2003

Confirmation No.: 3500

Title: SYSTEM AND METHOD FOR DETECTING FACE

SECOND
INFORMATION DISCLOSURE STATEMENT
TRANSMITTAL LETTER

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Enclosed is a SECOND Information Disclosure Statement and accompanying form PTO-1449 for the above-identified patent application.

- No additional fee for submission of an IDS is required.
- The fee of \$180.00 (1806) as set forth in 37 C.F.R. § 1.17(p) is also enclosed.
- A statement under 37 C.F.R. § 1.97(e) is also enclosed.
- A statement under 37 C.F.R. § 1.97(e), and the fee of \$180.00 (1806) as set forth in 37 C.F.R. § 1.17(p) are also enclosed.
- Charge _____ to Deposit Account No. 02-4800 for the fee due.
- A check in the amount of _____ is enclosed for the fee due.
- Charge _____ to credit card. Form PTO-2038 is attached.

The Director is hereby authorized to charge any appropriate fees under 37 C.F.R. §§ 1.16, 1.17 and 1.21 that may be required by this paper, and to credit any overpayment, to Deposit Account No. 02-4800. This paper is submitted in duplicate.

Respectfully submitted,

BURNS, DOANE, SWECKER & MATHIS, L.L.P.

By


Charles F. Wieland III

Registration No. 33,096

Date: May 21, 2004



Attorney's Docket No. 033808-007

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Sir:

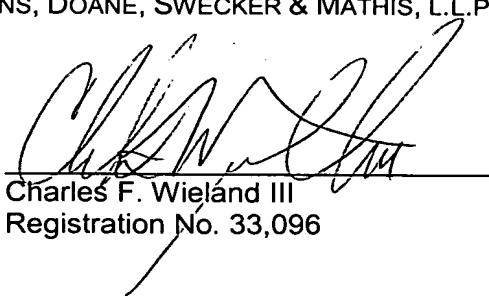
In accordance with the duty of disclosure as set forth in 37 C.F.R. § 1.56, the accompanying information is being submitted in accordance with 37 C.F.R. §§ 1.97 and 1.98.

To assist the Examiner, the documents are listed on the attached form PTO-1449. It is respectfully requested that an Examiner initialed copy of this form be returned to the undersigned.

Respectfully submitted,

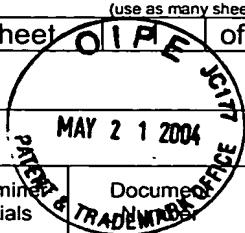
BURNS, DOANE, SWECKER & MATHIS, L.L.P.

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Substitute for form 1449A/PTO & 1449B/PTO		<i>Complete if Known</i>	
SECOND INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Application Number	10/699,879
		Filing Date	November 4, 2003
		First Named Inventor	Sang-min Yoon et al.
		Examiner Name	Unassigned
Sheet	1	of	1
		Attorney Docket Number	
		033808-007	



MAY 21 2004

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

NON-PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
	European Search Report dated February 26, 2004 for corresponding application EP 03 25 6953
	TAE-KYUNKIM ET AL., "Component-Based LDA Face Descriptor for Image Retrieval", Proceedings of the 13 th British Machine Vision Conference, 2002, pgs. 507-516, Vol. 2, Cardiff University, England
	DAVID J. OZIEM, "Face Recognition Techniques and the Implications of Facial Transformations", Bachelor Dissertation, Computer Science Department, 2002, pgs. 17-34, University of Bristol, England
	G.A. MOTA ET AL., "Face Detector Combining Eigenfaces, Neural Network and Bootstrap", Proc. Brazilian Symposium on neural Networks, 2000, page 290, Left-hand column, Paragraph 5,
	HYUN-CHUL KIM ET AL., "Face Recognition Using the Mixture-of-Eigenfaces Method", Pattern Recognition Letters, 2002, pgs. 1549-1588, Elsevier Science B.V.
	ALEIX M. MARTINEZ ET AL., "PCA Versus LDA", IEEE Transactions on Pattern Analysis and Machine Intelligence", 2001, pgs. 228-233, Vol. 23, No. 2, IEEE Inc. , New York, USA

Examiner Signature _____ **Date Considered** _____

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.
VA 157231-1